Search Notes



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Applicant(s)/Patent Under Reexamination

TAKUMAI, SUSUMU

Examiner

Art Unit

DEVONA E FAULK

2614

SEARCHED

Class	Subclass	Date	Examiner
381	303-310,56-59	9/12/08	DEF
381	303-310,56-59	7/18/09	DEF
381	303-310,56-59,1,17-19,102,92	8/29/10,9/12/10	DEF

SEARCH NOTES

Search Notes	Date	Examiner
assignee/inventor search	9/12/08	DEF
combined class/word search	12/2,5/08	DEF
additional search	7/18/09	DEF
addtional search	8/29,30/10,9/12/	DEF
	10	

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	combined class/word search	8/29/10,89/12/10	DEF
381	303-310,56-59,1,17-19	8/29/10,9/12/10	DEF

/DEVONA E FAULK/ Primary Examiner.Art Unit 2614

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